PROCEEDINGS OF SPIE

Advanced Optical Imaging Technologies IV

Xiao-Cong Yuan P. Scott Carney Kebin Shi Editors

10–11 October 2021 Nantong, China

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Published by SPIE

Volume 11896

Proceedings of SPIE 0277-786X, V. 11896

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Please use the following format to cite material from these proceedings: Author(s), "Title of Paper," in Advanced Optical Imaging Technologies IV, edited by Xiao-Cong Yuan, P. Scott Carney, Kebin Shi, Proc. of SPIE 11896, Seven-digit Article CID Number (DD/MM/YYYY); (DOI URL).

ISSN: 0277-786X ISSN: 1996-756X (electronic)

ISBN: 9781510646414 ISBN: 9781510646421 (electronic)

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